

# MOSFET Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted

Symbol	Parameter			Ratings	Units
V <sub>DS</sub>	Drain to Source Voltage			30	V
V <sub>GS</sub>	Gate to Source Voltage			±20	V
	Drain Current -Continuous (Package limited)	T <sub>C</sub> = 25°C		80	
I <sub>D</sub>	-Continuous (Silicon limited)	T <sub>C</sub> = 25°C		219	Α
	-Pulsed		(Note 1)	556	
E <sub>AS</sub>	Single Pulse Avalanche Energy		(Note 2)	673	mJ
PD	Power Dissipation			254	W
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature			-55 to +175	°C

## **Thermal Characteristics**

$R_{\theta JC}$	Thermal Resistance, Junction to Case TO220	0.59	°C/W
$R_{\thetaJA}$	Thermal Resistance, Junction to Ambient TO220	62	C/VV

## Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDP8860	FDP8860	TO220AB	Tube	N/A	50 units

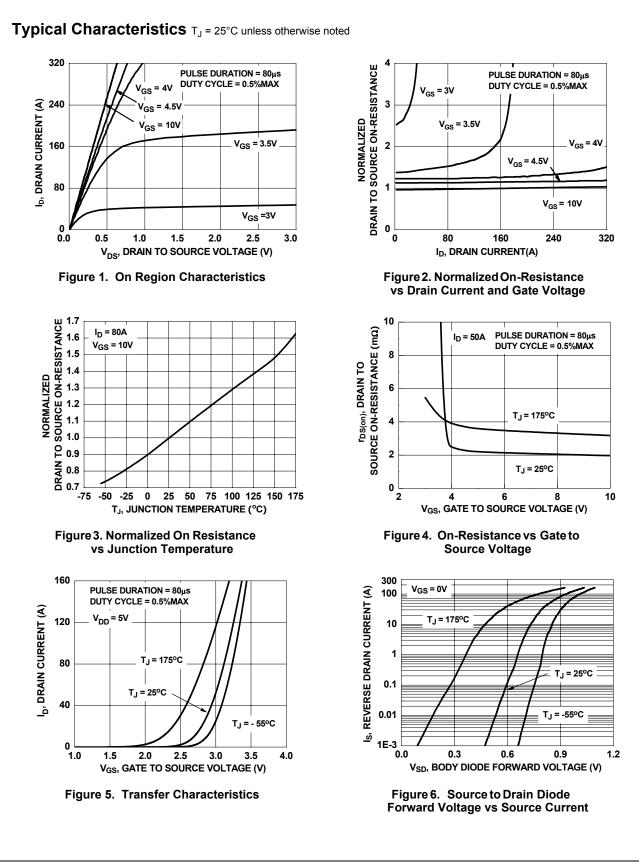
to

FDP8860
N-Channel
PowerTrench <sup>®</sup>
MOSFET

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units	
Off Chara	acteristics						
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	I <sub>D</sub> = 1mA, V <sub>GS</sub> = 0V	30			V	
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D$ = 1mA, referenced to 25°C		22		mV/°C	
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = 24V,$ $V_{GS} = 0V$ $T_{J} = 150^{\circ}C$			1 250	μA	
I <sub>GSS</sub>	Gate to Source Leakage Current	V <sub>GS</sub> = ±20V			±100	nA	
	acteristics			- <b>I</b>	+	ł.	
V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	1	1.6	2.5	V	
$\frac{\Delta V_{GS(th)}}{\Delta T_{.l}}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = 250 \mu A$ , referenced to 25°C		-9.6		mV/°C	
		V <sub>GS</sub> = 10V, I <sub>D</sub> = 80A		1.9	2.5		
r	Drain to Source On Registence	V <sub>GS</sub> = 5V, I <sub>D</sub> = 80A		2.0	2.8		
r <sub>DS(on)</sub> Drain to	Drain to Source On Resistance	V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 80A		2.1	2.9	mΩ	
		V <sub>GS</sub> = 10V, I <sub>D</sub> = 80A, T <sub>J</sub> = 150°C	2.9 3.8		3.8		
9fs	Forward Transconductance	V <sub>DS</sub> = 10V, I <sub>D</sub> = 80A		3.4		S	
Dynamic	Characteristics						
C <sub>iss</sub>	Input Capacitance			9200	12240	pF	
C <sub>oss</sub>	Output Capacitance	──V <sub>DS</sub> = 15V, V <sub>GS</sub> = 0V, f = 1MHz		1700	2260	pF	
C <sub>rss</sub>	Reverse Transfer Capacitance			1060	1590	pF	
R <sub>g</sub>	Gate Resistance	f = 1MHz		1.7		Ω	
Switching	g Characteristics						
t <sub>d(on)</sub>	Turn-On Delay Time			35	56	ns	
t <sub>r</sub>	Rise Time	$V_{DD} = 15V, I_D = 80A$		135	216	ns	
t <sub>d(off)</sub>	Turn-Off Delay Time	$-V_{GS}$ = 5V, $R_{GEN}$ = 3 $\Omega$		64	103	ns	
t <sub>f</sub>	Fall Time			59	95	ns	
Q <sub>g(TOT)</sub>	Total Gate Charge at 10V	$V_{GS} = 0V$ to 10V		158	222	nC	
Q <sub>g(5)</sub>	Total Gate Charge at 5V	$\frac{V_{GS} = 0V \text{ to } 10V}{V_{GS} = 0V \text{ to } 5V} V_{DD} = 15V I_D = 80A$		81	114	nC	
Q <sub>gs</sub>	Gate to Source Gate Charge	I <sub>D</sub> = 80A		27		nC	
Q <sub>gd</sub>	Gate to Drain "Miller" Charge			33		nC	
Drain-So	urce Diode Characteristics						
		V <sub>GS</sub> = 0V, I <sub>S</sub> = 80A		0.88	1.25		
V <sub>SD</sub>	Source to Drain Diode Forward Voltage	V <sub>GS</sub> = 0V, I <sub>S</sub> = 40A		0.81	1.2	V	
t <sub>rr</sub>	Reverse Recovery Time	I <sub>F</sub> = 80A, di/dt = 100A/μs		60	90	ns	

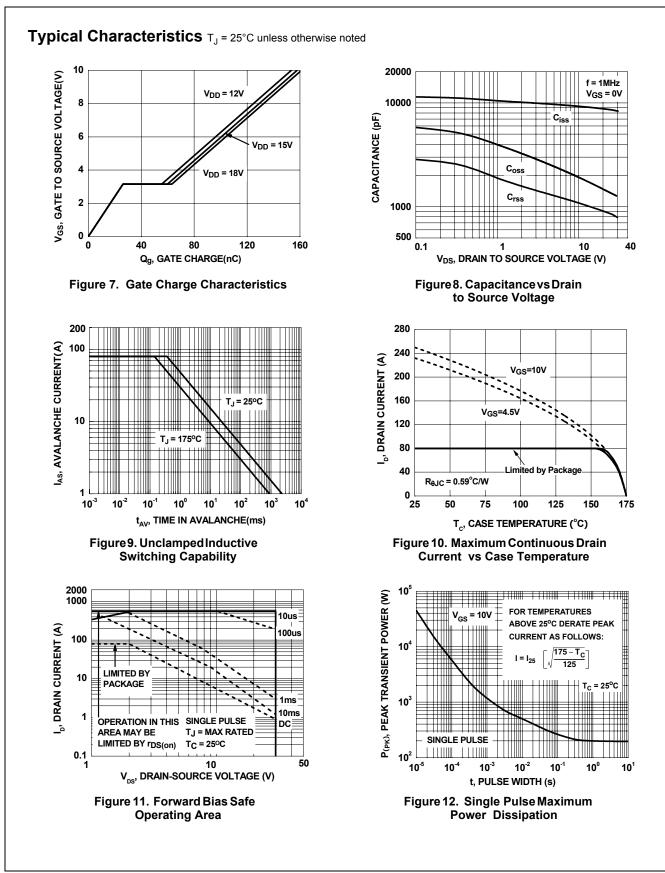
 $\mathsf{Q}_{\mathsf{rr}}$ 

**Notes: 1:** Pulse Test: Pulse Width <  $80\mu$ s, Duty cycle < 0.5%. **2:** Starting T<sub>J</sub> =25°C, L= 0.3mH, I<sub>AS</sub> = 67A, V<sub>DD</sub> = 27V, V<sub>GS</sub> = 10V.



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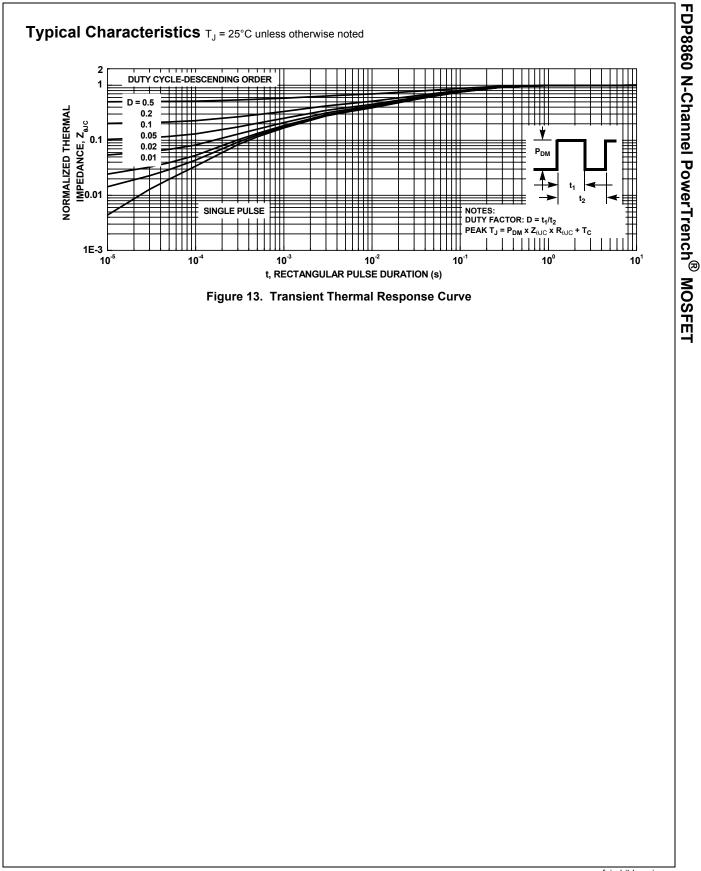




FDP8860 Rev.B

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